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DISTRIBUTION STATEMENT A. Approved for public release; distribution is unlimited.

1 SCODE							
1. SCOPE							
1.1 · Scope · This drawing describes deviwith 1.2.1 of MIL-STD-883, "Provisions for non-JAN devices".	ce requirement the use of	ents for class B MIL-STD-883 in	microcircuits in accordance conjunction with compliant				
1.2 Part number. The complete part num	ber shall t	e as shown in th	ne following example:				
<u>5962-89617</u> <u>01</u>		1_	X				
Drawing number Device t		Case outline (1.2.2)	Lead finish per MIL-M-38510				
1.2.1 <u>Device type</u> . The device type sha	11 identify	the circuit fur	nction as follows:				
Device type Generic num	ber	Circuit funct	tion				
01 AD767	.2-bit digital-to	o-analog converter					
1.2.2 Case outline. The case outline s and as follows:	hall be as	designated in ap	opendix C of MIL-M-38510,				
Outline letter		Case	outline				
L D	-9 (24-lead	, 1.280"x.310"x.	.200"), dual-in-line package				
1.3 Absolute maximum ratings.							
V _{CC} to power ground			0 V dc to +18 V dc				
V _{EE} to power ground			0 V dc to -18 V dc				
Digital inputs to power ground			-1.0 V dc to +7.0 V dc				
Reference input to reference ground			±12 V dc				
Bipolar offset to reference ground		. .	±12 V dc				
10 V span R to reference ground -			±12 V dc				
20 V span R to reference ground ±24 V dc							
Ref out or V_{OUT} short circuit duration $\frac{1}{2}$							
Storage temperature range							
Lead temperature (soldering, 10 sec	onds)		+300°C				
Power dissipation			1.0 W				
Thermal resistance, junction-to-cas	e (e _{.10})		See MIL-M-38510, appendix C				
Thermal resistance, junction-to-amb	ient (e _{JA})		80°C/W				
Junction temperature (T_{j})			+175°C				
-							
$\underline{1}/$ Indefinite short to power ground; mo	mentary sho	ert to V _{CC} .					
STANDARDIZED	SIZE						
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1.4	Recommended	operating	conditions.

2. APPLICABLE DOCUMENTS

2.1 Government specification, standard, and bulletin. Unless otherwise specified, the following specification, standard, and bulletin of the issue listed in that issue of the Department of Defense Index of Specifications and Standards specified in the solicitation, form a part of this drawing to the extent specified herein.

SPECIFICATION

MILITARY

MIL-M-38510

- Microcircuits, General Specification for.

STANDARD

MILITARY

MIL-STD-883

- Test Methods and Procedures for Microelectronics.

BULLETIN

MILITARY

MIL-BUL-103

- List of Standardized Military Drawings (SMD's).

(Copies of the specification, standard, and bulletin required by manufacturers in connection with specific acquisition functions should be obtained from the contracting activity or as directed by the contracting activity.)

- 2.2 Order of precedence. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing shall take precedence.
 - 3. REQUIREMENTS
- 3.1 Item requirements. The individual item requirements shall be in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices" and as specified herein.
- 3.2 Design, construction, and physical dimensions. The design, construction, and physical dimensions shall be as specified in MIL-M-38510 and herein.
 - 3.2.1 Terminal connections. The terminal connections shall be as specified on figure 1.
 - 3.2.2 Functional block diagram. The functional block diagram shall be as specified on figure 2.
 - 3.2.3 Case outline. The case outline shall be in accordance with 1.2.2 herein.

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TABLE I. Electrical performance characteristics. Conditions 1/ -55°C \leq TA \leq +1 $\overline{2}$ 5°C unless otherwise specified Test Symbol Group A Limits Unit subgroups Min Max All bits with positive errors on and all bits with negative 1,2,3 1±1.0 LSB RA Relative accuracy errors on Differential nonlinearity DNL Major carry errors 1,2,3 ±1.0 LSB %FSR All bits on, TA = +25°C 1 ±.20 Gain error 2/ ΑE 2,3 1±30 ppm/ Gain temperature ΔAE |All bits on coefficient ΔT ±2.0 |All bits off, TA = +25°C 1 LSB Unipolar offset error Vos 1±3.0 ppm/ C |All bits off 2,3 Unipolar offset Δ V_{OS} temperature coefficient ΔΤ MSB on, all other bits off, bipolar mode, $T_A = +25$ °C %FSR Bipolar zero error 2/ 1 ±.10 BPZE ΔBPZE MSB on, all other bits off, Bipolar zero temperature 2,3 ±10 gpm/ coefficient |bipolar mode 115 125 |T_A = +25°C kΩ Reference input RIN resistance 3/ Unipolar mode, 1.1 mA external 1,2,3 9.9 110.10! V Reference output voltage VREF lload 1,2,3 |±5.0 Output current 3/ mΑ IOUT 40 Output short circuit 1,2,3 mΑ ISC current 3/ See footnotes at end of table. STANDARDIZED SIZE Α 5962-89617 MILITARY DRAWING **DEFENSE ELECTRONICS SUPPLY CENTER REVISION LEVEL** SHEET DAYTON, OHIO 45444

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2,3 ±20 2,3 ±20 2,	±20
2,3 ±20 -11.4 V \(\) VEE \(\) -16.5 V,	±20
Power supply current ICC	±20
ICC	+13 mA -23 V 0.8 V
$I_{EE} \qquad V_{EE} = -16.5 \text{ V, } T_{A} = +25^{\circ}\text{C,} \qquad \qquad -23 $ $ -23 $	-23 V 0.8 V
$I_{EE} \qquad V_{EE} = -16.5 \text{ V, } T_{A} = +25^{\circ}\text{C,}$ all bits off $Digital input high voltage \qquad V_{IH}$ $Digital input low voltage \qquad V_{IL}$ $2,3 \qquad 0.7$ $Digital input high current \qquad I_{IH} \qquad V_{IH} = 5.5 \text{ V, } T_{A} = +25^{\circ}\text{C}$ $1 \qquad 10$	0.8 V
Digital input low voltage V_{IL} 1 0.8 2,3 0.7 Digital input high current I_{IH} $V_{IH} = 5.5 \text{ V}, T_{A} = +25^{\circ}\text{C}$ 1 10	0.8 V
2,3 0.7 Digital input high current I _{IH} V _{IH} = 5.5 V, T _A = +25°C 1 10	
Digital input high current I_{IH} $V_{IH} = 5.5 \text{ V}, T_{A} = +25^{\circ}\text{C}$ 1 10	0.7
No. 10 No	10 μA
Digital input low current $ I_{IL} $ $ V_{IL} = 0.0 \text{ V}$, $T_A = +25 \text{ C}$ $ I $ $ 5.0 \text{ C} $	5.0 μA
Data setup time t _{DS} See figure 3 4/ 9,10,11 90	l ns
Data hold time t _{DH} 9,10,11 20	ns
CS pulse width t _{CP} 9,10,11 90	l Ins

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TABLE I. Electrical performance characteristics - Continued.							
Test	 Symbol		ons 1/	Group A	Limits		Unit
		-55°C < TA < unless otherwi	subgroups 	 Min 	 Max 		
Output voltage settling	t _{SL}	R _L = 2.0 kΩ, C _l = 500 pF,	RFB = 10 kΩ	9,10,11		4.0	μS
CTINC		see figure 3 <u>4</u> /	$R_{FB} = 5.0 \text{ k}\Omega$	9,10,11] 	3.0	-

- $^{1/}$ V_{CC} = +15 V, V_{EE} = -15 V, $^{50}\Omega$ resistor between pin 6 and pin 7, $\overline{\text{CS}}$ = logic 0, $^{1/}$ V_{IH} = 2.0 V, V_{IL} = 0.8 V and unipolar 10 V configuration, unless otherwise specified.
- 2/ Adjustable to 0 V.
- 3/ If not tested, shall be guaranteed to the limits specified in table I.
- 4/ V_{CC} = +12 V or +15 V and V_{EE} = -12 V or -15 V.
- 3.3 Electrical performance characteristics. Unless otherwise specified herein, the electrical performance characteristics are as specified in table I and shall apply over the full ambient operating temperature range.
- 3.4 Electrical test requirements. The electrical test requirements shall be the subgroups specified in table II. The electrical tests for each subgroup are described in table I.
- 3.5 Marking. Marking shall be in accordance with MIL-STD-883 (see 3.1 herein). The part shall be marked with the part number listed in 1.2 herein. In addition, the manufacturer's part number may also be marked as listed in MIL-BUL-103 (see 6.6 herein).
- 3.6 Certificate of compliance. A certificate of compliance shall be required from a manufacturer in order to be listed as an approved source of supply in MIL-BUL-103 (see 6.6 herein). The certificate of compliance submitted to DESC-ECS prior to listing as an approved source of supply shall affirm that the manufacturer's product meets the requirements of MIL-STD-883 (see 3.1 herein) and the requirements herein.
- 3.7 Certificate of conformance. A certificate of conformance as required in MIL-STD-883 (see 3.1 herein) shall be provided with each lot of microcircuits delivered to this drawing.
- 3.8 Notification of change. Notification of change to DESC-ECS shall be required in accordance with MIL-STD-883 (see 3.1 herein).
- 3.9 Verification and review. DESC, DESC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.

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Device type 01 L Case outline |Terminal number|Terminal symbol 20 V SPAN 1 2 10 V SPAN 3 SUM JCT 4 BIP OFF 5 AGND REF OUT 6 7 REF IN 8 v_{CC} 9 VOUT 10 V_{EE} 11 CS DGND 12 DB_O(LSB) 13 14 DB_1 15 DB_2 16 DB_3 17 DB_4 18 DB₅ 19 DB₆ 20 DB7 21 DB8 22 DBg 23 DB₁₀ 24 $DB_{11}(MSB)$

FIGURE 1. Terminal connections.

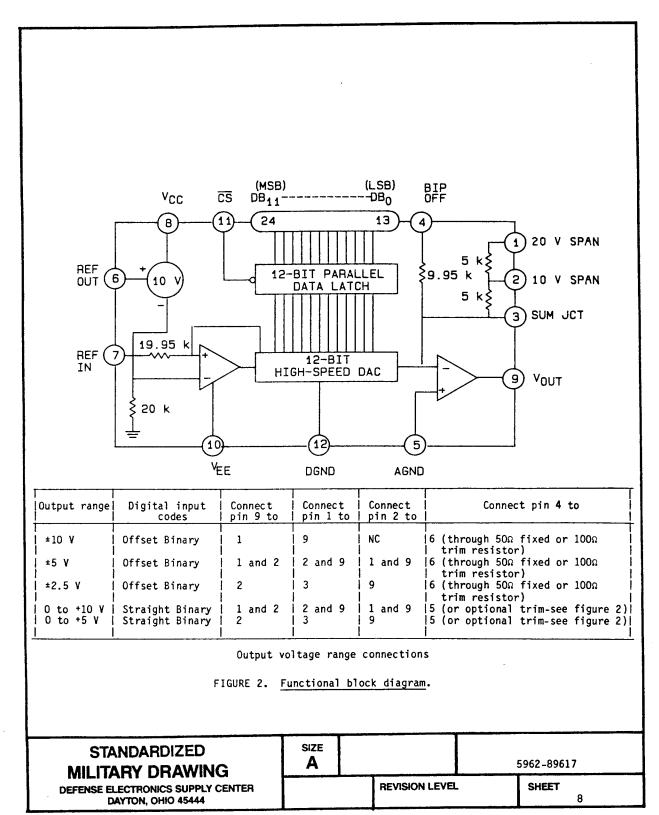
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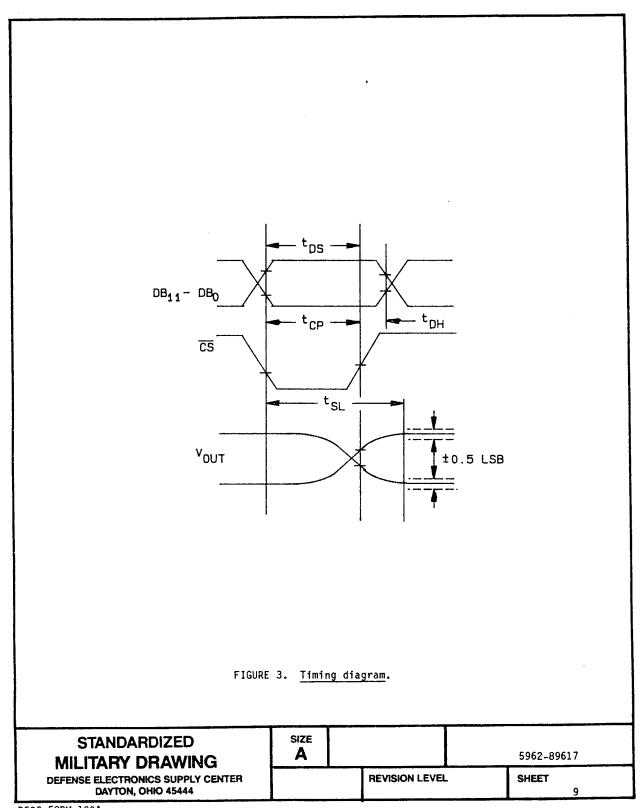
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4. OUALITY ASSURANCE PROVISIONS

- 4.1 Sampling and inspection. Sampling and inspection procedures shall be in accordance with section 4 of MIL-M-38510 to the extent specified in MIL-STD-883 (see 3.1 herein).
- 4.2 Screening. Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:
 - a. Burn-in test, method 1015 of MIL-STD-883.
 - (1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see $3.6\ \text{herein}$).
 - (2) $T_A = +125^{\circ}C$, minimum.
 - b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.
- 4.3 Quality conformance inspection. Quality conformance inspection shall be in accordance with method 5005 of MIL-SID-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.
 - 4.3.1 Group A inspection.
 - a. Tests shall be as specified in table II herein.
 - b. Subgroups 5, 6, 7, and 8 in table I, method 5005 of MIL-STD-883 shall be omitted.
 - 4.3.2 Groups C and D inspections.
 - a. End-point electrical parameters shall be as specified in table II herein.
 - b. Steady-state life test conditions, method 1005 of MIL-STD-883.
 - (1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.6 herein).
 - (2) $T_A = +125$ °C, minimum.
 - (3) Test duration: 1,000 hours, except as permitted by method 1005 of MIL-STD-883.

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TABLE II. Electrical test requirements.

MIL-STD-883 test requirements	Subgroups (per method 5005, table I)
Interim electrical parameters (method 5004)	1
Final electrical test parameters (method 5004)	1*, 2, 3
Group A test requirements (method 5005)	1, 2, 3, 4**, 9**, 10**, 11**
Group C and D end-point electrical parameters (method 5005)	1

^{*} PDA applies to subgroup 1.

5. PACKAGING

5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-M-38510.

NOTES

- 6.1 Intended use. Microcircuits conforming to this drawing are intended for use when military specifications do not exist and qualified military devices that will perform the required function are not available for OEM application. When a military specification exists and the product covered by this drawing has been qualified for listing on QPL-38510, the device specified herein will be inactivated and will not be used for new design. The QPL-38510 product shall be the preferred item for all applications.
- 6.2 Replaceability. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.
- 6.3 Configuration control of SMD's. All proposed changes to existing SMD's will be coordinated with the users of record for the individual documents. This coordination will be accomplished in accordance with MIL-STD-481 using DD Form 1693, Engineering Change Proposal (Short Form).
- 6.4 Record of users. Military and industrial users shall inform Defense Electronics Supply Center when a system application requires configuration control and the applicable SMD. DESC will maintain a record of users and this list will be used for coordination and distribution of changes to the drawings. Users of drawings covering microelectronics devices (FSC 5962) should contact DESC-ECS, telephone (513) 296-6022.
- 6.5 Comments. Comments on this drawing should be directed to DESC-ECS, Dayton, Ohio 45444, or telephone (513) 296-5375.

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^{**} Subgroups 4, 9, 10 and 11, if not tested, shall be guaranteed to the limits specified in table I.

6.6 Approved source of supply. An approved source of supply is listed in MIL-BUL-103. Additional sources will be added to MIL-BUL-103 as they become available. The vendor listed in MIL-BUL-103 has agreed to this drawing and a certificate of compliance (see 3.6 herein) has been submitted to and accepted by DESC-ECS. The approved source of supply listed below is for information purposes only and is current only to the date of the last action of this document.

Military drawing part number	Vendor CAGE number	Vendor similar part number <u>1</u> /
5962-8961701LX	24355	AD767SD/883B

1/ Caution. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.

Vendor CAGE number

24355

Vendor name and address

Analog Devices
Route 1 Industrial Park
P.O. Box 9106
Norwood, MA 02062
Point of contact: 804 Woburn Street
Wilmington, MA 01887

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